STP6N90K5



N-channel 900 V, 0.91 Ω typ., 6 A MDmesh™ K5 Power MOSFET in a TO-220 package

Datasheet - production data

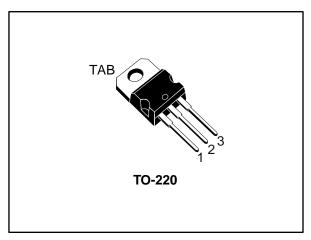
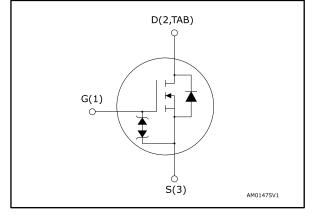


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	Ι _D
STP6N90K5	900 V	1.10 Ω	6 A

- Industry's lowest R_{DS(on)} x area
- Industry's best FoM (figure of merit)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packing
STP6N90K5	6N90K5	TO-220	Tube

Contents STP6N90K5

Contents

1	Electric	cal ratings	3
2	Electric	cal characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	rcuits	8
4	Packag	e information	9
	4.1	TO-220 type A package information	10
5	Revisio	n history	12

STP6N90K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol Parameter		Value	Unit
V _G s	Gate-source voltage	± 30	V
I _D	Drain current (continuous) at T _C = 25 °C	6	Α
ΙD	Drain current (continuous) at T _C = 100 °C	4	Α
I _D ⁽¹⁾	Drain current (pulsed)		Α
P _{TOT}	Total dissipation at T _C = 25 °C	110	W
dv/dt (2)	Peak diode recovery voltage slope	4.5	1//
dv/dt (3)	MOSFET dv/dt ruggedness 50		V/ns
Tj	Operating junction temperature range	FF to 150	°C
T _{stg}	Storage temperature range	- 55 to 150	°C

Notes:

Table 3: Thermal data

Symbol	Symbol Parameter		Unit	
R _{thj-case}	R _{thj-case} Thermal resistance junction-case			
R _{thj-amb}	Thermal resistance junction-ambient	62.5	°C/W	

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	2	Α
Eas	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	210	mJ

⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \le 6$ A, di/dt ≤ 100 A/µs; VDs peak < V(BR)DSS, VDD = 450 V.

 $^{^{(3)}}V_{DS} \le 720 \text{ V}$

Electrical characteristics STP6N90K5

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 5: On/off-state

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	900			V
	Zero gate voltage drain current	$V_{GS} = 0 \text{ V}, V_{DS} = 900 \text{ V}$			1	μΑ
I _{DSS}		$V_{GS} = 0 \text{ V}, V_{DS} = 900 \text{ V}$ $T_{C} = 125 \text{ °C}^{(1)}$			50	μΑ
Igss	Gate body leakage current	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			±10	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DD} = V_{GS}$, $I_D = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 3 A		0.91	1.10	Ω

Notes:

Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	342	1	pF
Coss	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	31	1	pF
Crss	Reverse transfer capacitance	$V_{GS} = 0 V$	-	1.2	1	pF
C _{o(tr)} (1)	Equivalent capacitance time related	V _{DS} = 0 to 720 V,	-	55	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	V _{GS} = 0 V	-	20	-	pF
Rg	Intrinsic gate resistance	f = 1 MHz, I _D = 0 A	-	6.4	-	Ω
Qg	Total gate charge	V _{DD} = 720 V, I _D = 6 A	-	11	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	2.5	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15: "Test circuit for gate charge behavior")	-	7	-	nC

Notes:

⁽¹⁾ Defined by design, not subject to production test.

 $^{^{(1)}}$ $C_{o(tr)}$ is a constant capacitance value that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DS}

 $^{^{(2)}}$ Co_(er) is a constant capacitance value that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

Table 7: Switching times

33						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V_{DD} = 450 V, I_{D} = 3 A, R_{G} = 4.7 Ω	ı	12.4	1	ns
tr	Rise time	V _{GS} = 10 V	ı	12.2	ı	ns
t _{d(off)}	Turn-off delay time	(see Figure 14: "Test circuit for resistive load switching times" and	-	30.4	-	ns
tf	Fall time	Figure 19: "Switching time waveform")	-	15.5	-	ns

Table 8: Source-drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		6	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		24	Α
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 6 A, V _{GS} = 0 V	-		1.5	V
t _{rr}	Reverse recovery time	I _{SD} = 6 A, di/dt = 100 A/µs, V _{DD} = 60 V (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	342		ns
Qrr	Reverrse recovery charge		-	3.13		μC
I _{RRM}	Reverse recovery current		-	18.3		Α
t _{rr}	Reverse recovery time	I _{SD} = 6 A, di/dt = 100 A/µs,	-	536		ns
Qrr	Reverse recovery charge	V _{DD} = 60 V, T _i = 150 °C (see Figure 16: "Test circuit for inductive load switching and diode recovery times")	-	4.42		μC
I _{RRM}	Reverse recovery current		-	16.5		А

Notes:

Table 9: Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}, I_D = 0 \text{ A}$	30	-		V

The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

2.1 Electrical characteristics (curves)

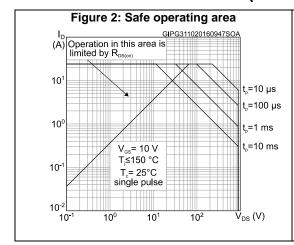
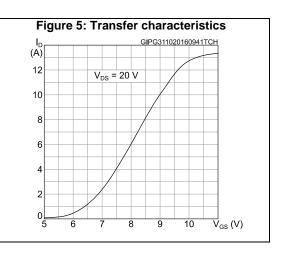
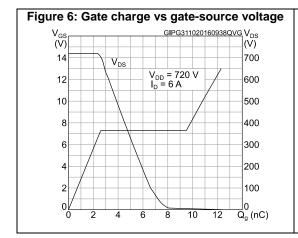


Figure 3: Thermal impedance $K \\ \bar{\delta} = 0.5$ $\bar{\delta} = 0.2$ $\bar{\delta} = 0.1$ $\delta = 0.01$ $\bar{\delta} = 0.05$ $\bar{\delta} = 0.05$ $\bar{\delta} = 0.01$ $\bar{\delta} = 0.02$ $\bar{\delta} = 0.01$ $\bar{\delta} = 0.02$ $\bar{\delta} = 0.01$ $\bar{\delta} = 0.01$





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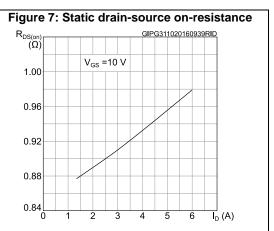


Figure 8: Capacitance variations

C GIPG311020160937CVR

103

104

105

C ISS

C OSS

C CRSS

1000

1001

1011

102

V DS (V)

Figure 10: Normalized on-resistance vs temperature

R_{DS(on)} GIPG311020160944RON
(norm.)

2.6 V_{GS} = 10 V

2.2

1.8

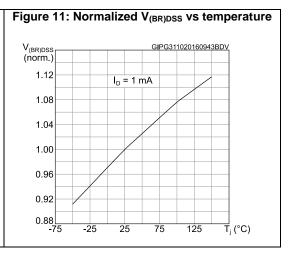
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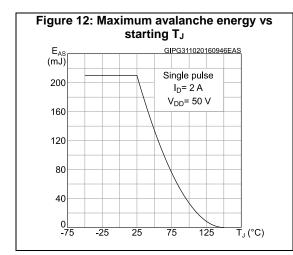
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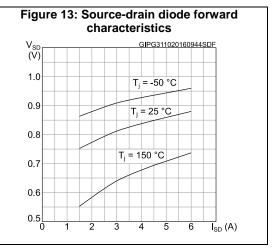
0.6

0.2

-75 -25 25 75 125 T_j (°C)







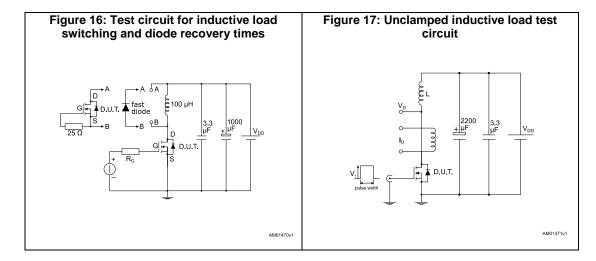
Test circuits STP6N90K5

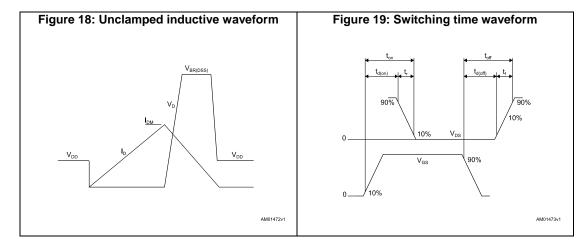
3 Test circuits

Figure 14: Test circuit for resistive load switching times

Figure 15: Test circuit for gate charge behavior

Figure 15: Test circuit for gate charge behavior





STP6N90K5 Package information

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



4.1 TO-220 type A package information

Figure 20: TO-220 type A package outline

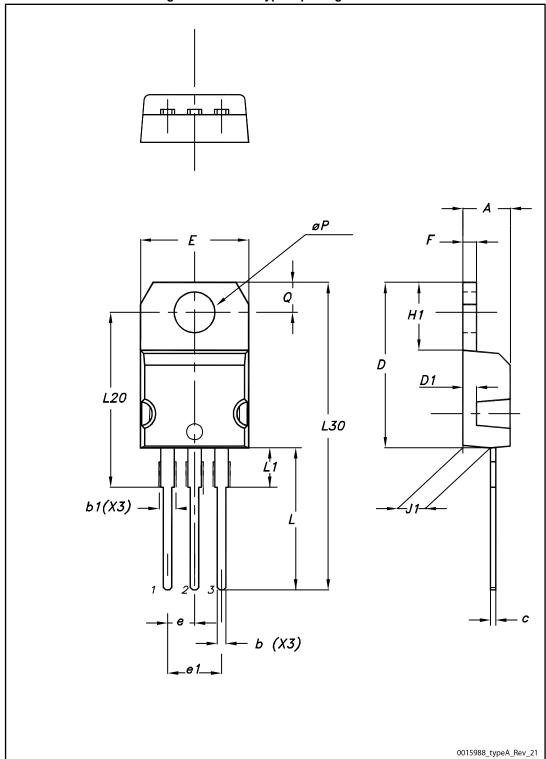


Table 10: TO-220 type A mechanical data

Dim	_	mm	
Dim.	Min.	Тур.	Max.
Α	4.40		4.60
b	0.61		0.88
b1	1.14		1.55
С	0.48		0.70
D	15.25		15.75
D1		1.27	
Е	10.00		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13.00		14.00
L1	3.50		3.93
L20		16.40	
L30		28.90	
øΡ	3.75		3.85
Q	2.65		2.95

Revision history STP6N90K5

5 Revision history

Table 11: Document revision history

Date	Revision	Changes
02-Nov-2016	1	First release.

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